

**Search Notes**

Application/Control No.

10/709,815

Examiner

Ahshik Kim

Applicant(s)/Patent under  
Reexamination

BONALLE ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	379	2/10/2006	AK
↓	380	↓	↓
	381		
	384		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
same as	above	9/12/2006	AK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewd parent case 09764,688	2/10/2006	AK
Updated search	9/12/2006	AK